## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Kanako KITAYAMA et al.

Group Art Unit: 2812

Application No.: 10/574,893

Filed: August 9, 2006 Docket No.: 127642

For: SEMICONDUCTOR DEVICE MANUFACTURING METHOD

## **INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. An English language Abstract of one or more non-English language reference is attached. See Reference 1.
- 3. Reference 1 corresponds to JP-A-2001-089859, which was previously cited in an Information Disclosure Statement filed on April 6, 2006.

Respectfully submitted

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JAO:DRK/abs

Date: May 2, 2007

OLIFF & BERRIDGE, PLC P.O. Box 19928 Alexandria, Virginia 22320 Telephone: (703) 836-6400 DEPOSIT ACCOUNT USE AUTHORIZATION Please grant any extension necessary for entry; Charge any fee due to our Deposit Account No. 15-0461

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Date: May 2, 2007